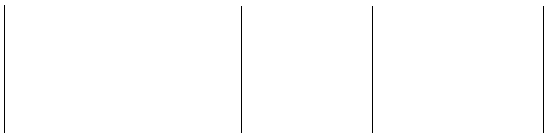
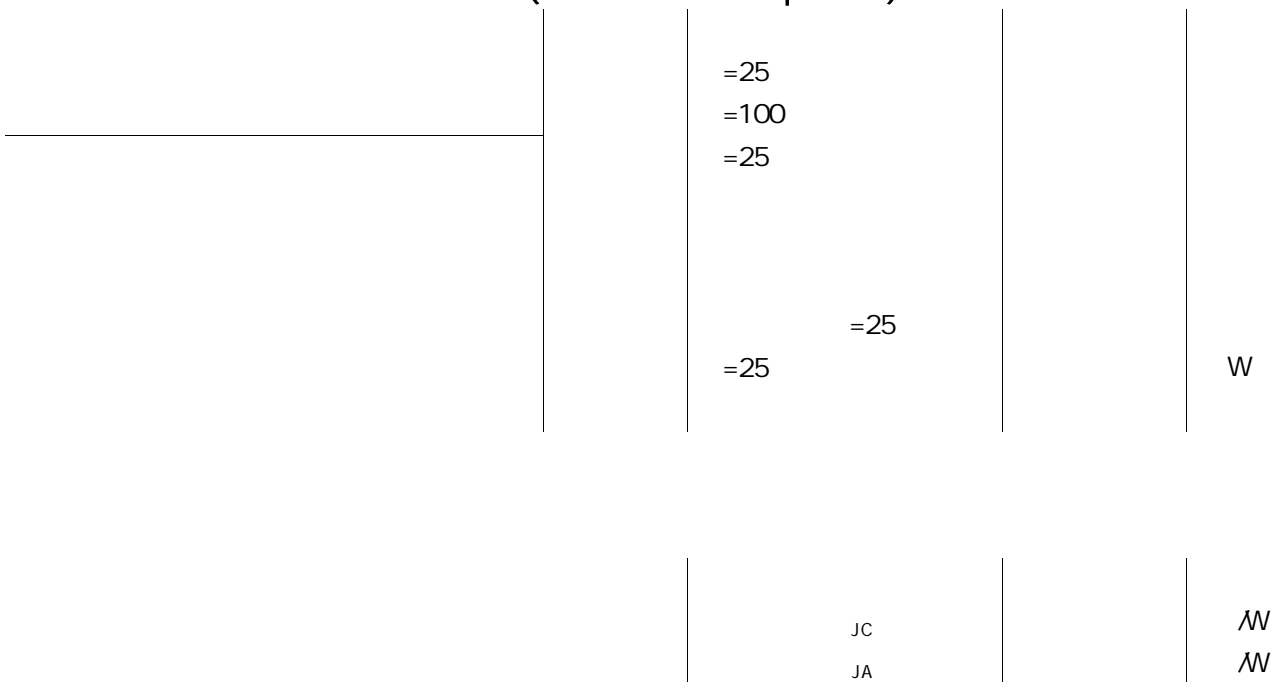




			$\Omega$
			$\Omega$



=25 (unless otherwise specified)





=25 (unless otherwise specified)

		$\mu$				
		$\mu$				
		=25				$\mu$
		=100				
						$\Omega$
	fs					
		Open, f=1MHz				$\Omega$

		=60V, f=1MHz				
Reverse Transfer Capacitance						
Turn off Delay Time	d(off)	$\Omega$				
	f					

		$dt=500A/\mu$				



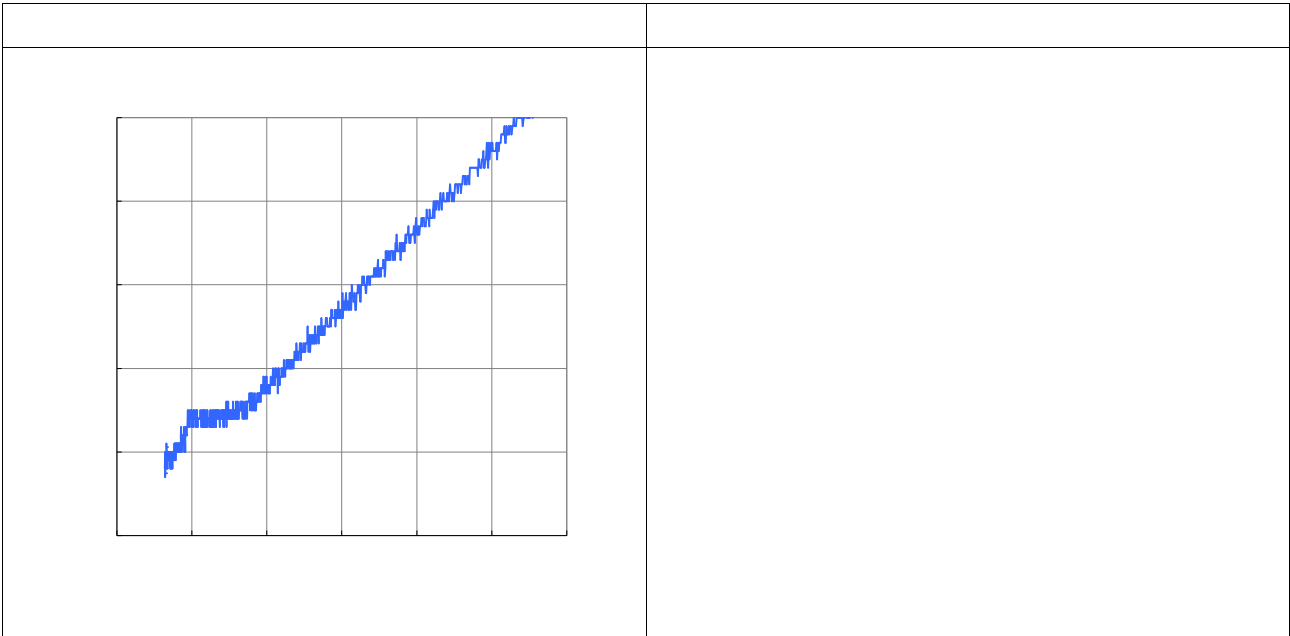


Figure 9. Maximum Safe Operating Area

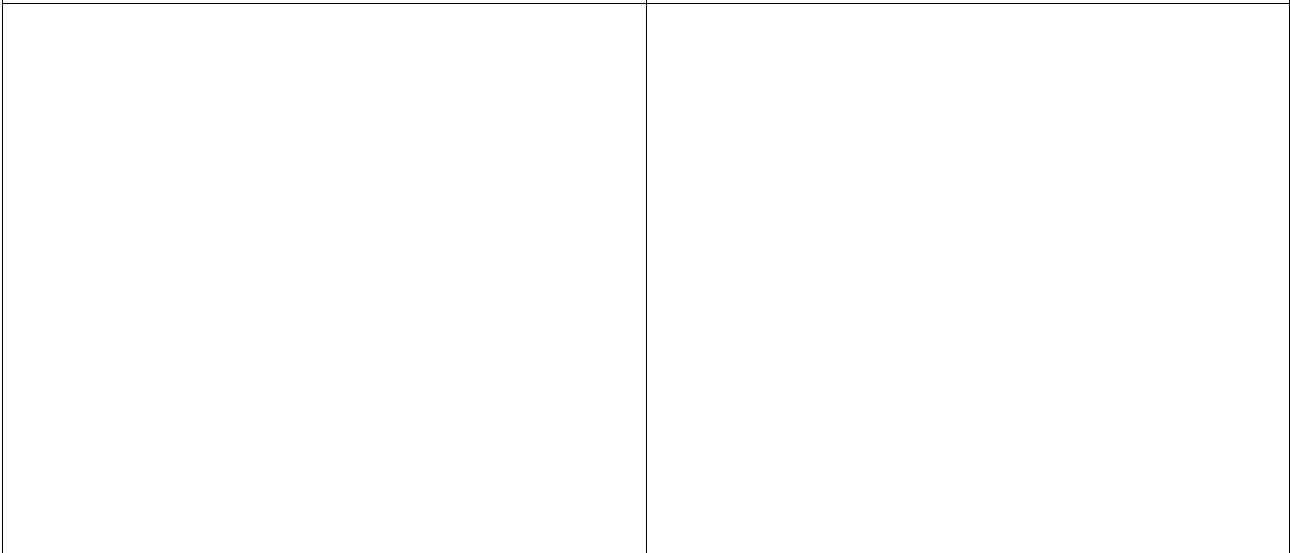
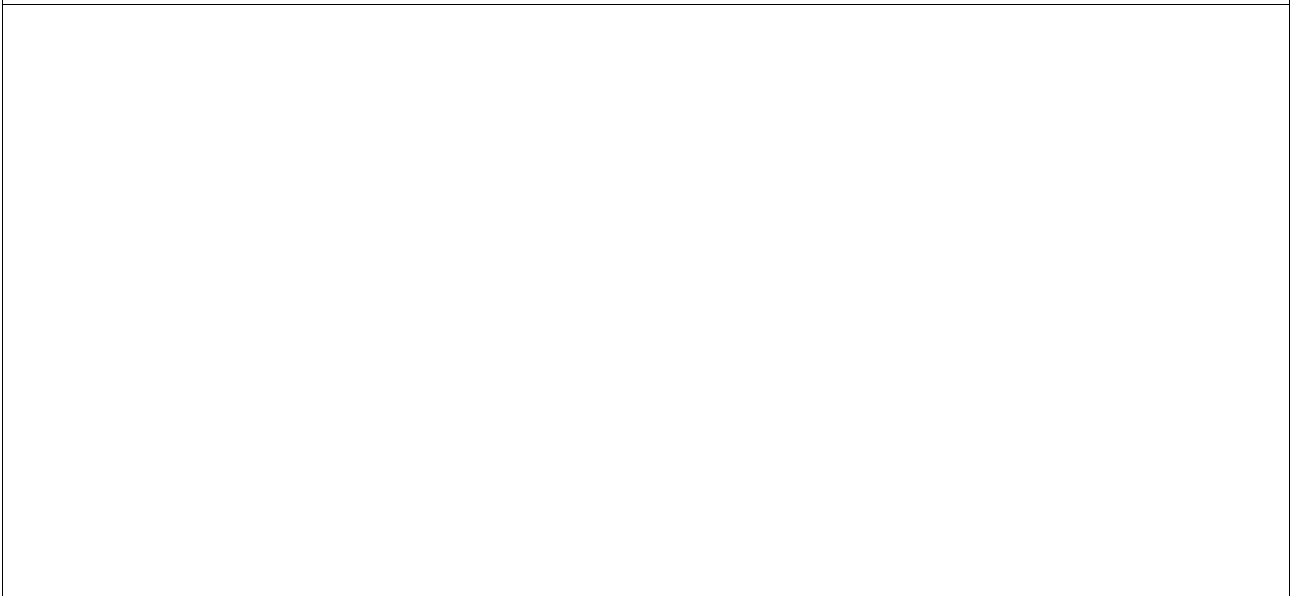


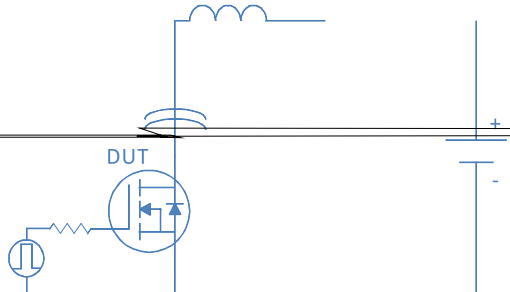
Figure 11. Normalized Maximum Transient Thermal Impedance, Junction-to-Case





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 <p>The diagram shows a circuit for testing a diode (DUT). A current source is connected in series with a resistor and the DUT. The DUT is connected to an inductor, which is then connected to a DC voltage source. The voltage source has a positive terminal (+) and a negative terminal (-).</p>	
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